

SILICON POWER TRANSISTOR 2SC3569

NPN SILICON TRIPLE DIFFUSED TRANSISTOR FOR HIGH-VOLTAGE HIGH-SPEED SWITCHING

The 2SC3569 is a mold power transistor developed for high-voltage high-speed switching, and is ideal for use in drivers such as switching regulators, DC/DC converters, and high-frequency power amplifiers.

FEATURES

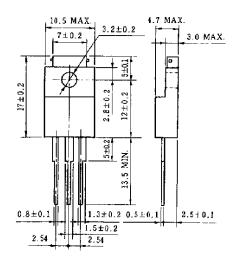
- Mold package that does not require an insulating board or insulation bushing
- Low collector saturation voltage:
 Vce(sat) = 1.0 V MAX. (@ 0.7 A)
- Fast switching speed: $t_{\rm f} \leq 1.0~\mu {\rm s~MAX.}~(@~0.7~{\rm A})$
- Wide base reverse-bias SOA:
 VCEX(SUS) = 450 V MIN. (@ 0.5 A)

ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

Parameter	Symbol	Ratings	Unit	
Collector to base voltage	Vcво	500	V	
Collector to emitter voltage	VCEO	400	V	
Emitter to base voltage	V _{EBO}	7.0	V	
Collector current (DC)	Ic(DC)	2.0	Α	
Collector current (pulse)	Ic(pulse)*	4.0	Α	
Base current (DC)	I _{B(DC)}	1.0	Α	
Total power dissipation	P _T (Tc = 25°C)	15	W	
Total power dissipation	P⊤ (Ta = 25°C)	2.0	W	
Junction temperature	Tj	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

^{*} PW \leq 300 μ s, duty cycle \leq 10%

PACKAGE DRAWING (UNIT: mm)





Electrode Connection

- 1. Base
- 2. Collector
- 3. Emitter

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

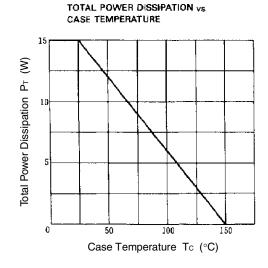
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector to emitter voltage	VCEO(SUS)	Ic = 0.5 A, Ів1 = 0.1 A, L = 1 mH	400			V
Collector to emitter voltage	VCEX(SUS)1	Ic = 0.5 A, I _{B1} = $-I_{B2}$ = 0.1 A, L = 180 μ H, clamped	450			V
Collector to emitter voltage	VCEX(SUS)2	Ic = 1.0 A, I _{B1} = 0.2 A, $-I_{B2}$ = 0.1 A, L = 180 μ H, clamped	400			V
Collector cutoff current	Ісво	V _{CB} = 400 V, I _E = 0			10	μΑ
Collector cutoff current	ICER	$V_{CE} = 400 \text{ V}, \text{ R}_{BE} = 51 \Omega, \text{ Ta} = 125 ^{\circ}\text{C}$			1.0	mA
Collector cutoff current	ICEX1	Vce = 400 V, Vbe(OFF) = -1.5 V			10	μΑ
Collector cutoff current	ICEX2	$V_{CE} = 400 \text{ V}, V_{BE(OFF)} = -1.5 \text{ V},$ $Ta = 125^{\circ}C$			1.0	mA
Emitter cutoff current	ІЕВО	V _{EB} = 5.0 V, I _C = 0			10	μΑ
DC current gain	hFE1*	Vce = 5.0 V, Ic = 0.2 A	20		80	
DC current gain	hFE2*	Vce = 5.0 V, Ic = 0.5 A	10			
Collector saturation voltage	V _{CE(sat)} *	Ic = 0.7 A, I _B = 0.14 A			1.0	٧
Base saturation voltage	V _{BE(sat)} *	Ic = 0.7 A, Iв = 0.14 A			1.2	V
Turn-on time	ton	$Ic = 0.7 \text{ A}, R_L = 214 \Omega,$			1.0	μs
Storage time	tstg	$I_{B1} = -I_{B2} = 0.14 \text{ A}, V_{CC} \cong 150 \text{ V}$ Refer to the test circuit.			2.5	μs
Fall time	tf	Tiolor to the test offcult.			1.0	μs

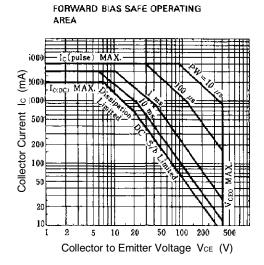
^{*} Pulse test PW \leq 350 μ s, duty cycle \leq 2%

hfe CLASSIFICATION

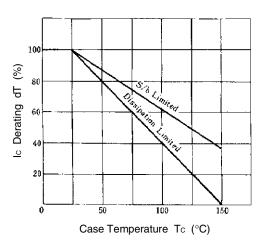
Marking	М	L	K
H _{FE1}	20 to 40	30 to 60	40 to 80

TYPICAL CHARACTERISTICS (Ta = 25°C)

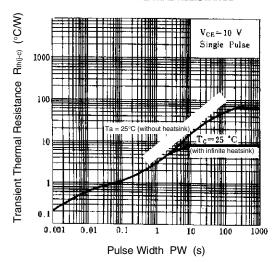




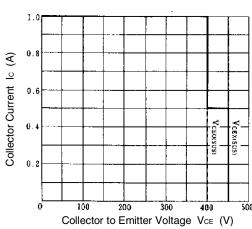
DERATING CURVE OF SAFE OPERATING AREA



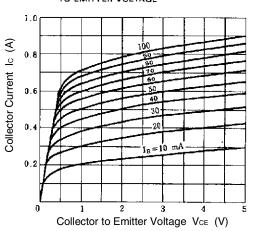
TRANSIENT THERMAL RESISTANCE



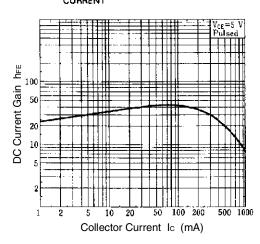
REVERSE BIAS SAFE OPERATING AREA



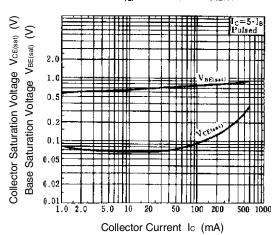
COLLECTOR CURRENT $_{\text{VS.}}$ COLLECTOR TO EMITTER VOLTAGE



DC CURRENT GAIN vs. COLLECTOR CURRENT

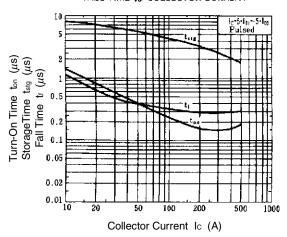


BASE AND COLLECTOR SATURATION VOLTAGE VS. COLLECTOR CURRENT

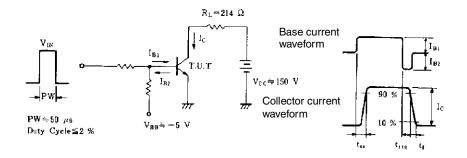


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TURN ON TIME, STORAGE TIME AND FALL TIME VS. COLLECTOR CURRENT



SWITCHING TIME (t_{on},t_{stg},t_{r}) TEST CIRCUIT



[MEMO]

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